

18 + 1 channel buffer for TFT-LCD panels

Features

■ Wide supply voltage: 5.5V to 16.8V

■ Low operating current: 8mA typical at 25°C

■ Bandwidth at -3dB: 3.5MHz

■ High output current COM amplifier: ±150mA

■ Industrial temperature range: -40°C to +95°C

■ Small package: TQFP48 ePad

Application

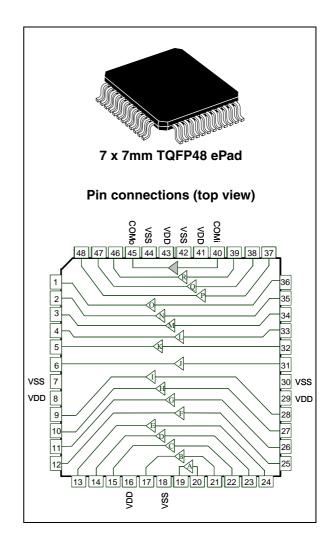
■ TFT liquid crystal display (LCD)

Description

The TSL1018 is composed of 18 + 1 channel buffers which are used to buffer the reference voltage for gamma correction in thin film transistor (TFT) liquid crystal displays (LCD).

One "COM" amplifier is able to deliver high output current value, up to ± 150 mA. Amplifiers A and B feature positive single supply inputs for common mode voltage, thus can be used for highest gamma voltages. The amplifiers C to R inclusive, and the COM amplifier, feature negative single supply inputs and are dedicated to the lowest gamma voltages.

The TSL1018 is fully characterized and guaranteed over a wide industrial temperature range (-40 to $+95^{\circ}$ C).



1 Absolute maximum ratings and operating conditions

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DD}	Supply voltage	18	V
V _{IN}	Input voltage	V _{SS} -0.5V to V _{DD} +0.5V	V
l _{out}	Output current (A to R buffers) Output current (COM buffer)	40 150	mA
R _{THJA}	Thermal resistance junction to ambient for TQFP48 ePad not thermally connected to PCB ePad thermally connected to PCB	85 36	°C/W
P _D	Power dissipation ⁽¹⁾ for TQFP48 ePad ePad not thermally connected to PCB ePad thermally connected to PCB	1470 3470	mW
T _{LEAD}	Lead temperature (soldering 10 seconds)	260	°C
T _{STG}	Storage temperature	-65 to +150	°C
T _J	Junction temperature	150	°C
ESD	Human body model (HBM) ⁽²⁾	2000	
	Machine model (MM) ⁽³⁾	200	V
	Charged device model (CDM) (4)	1500	

^{1.} P_D is calculated with $T_{amb} = 25$ °C, $T_J = 150$ °C and R_{THJA} .

Table 2. Operating conditions

Symbol	Parameter	Value	Unit	
V _{CC}	Supply voltage (V _{DD} - V _{SS})	5.5 to 16.8	V	
T _{amb}	Ambient temperature	-40 to +95	°C	
V	Input voltages for buffers A & B	V_{SS} + 1.5V to V_{DD}	V	
V _{IN}	Input voltages for buffers C to R & COM	V _{SS} to V _{DD} - 1.5V	V	

^{2.} Human body model: a 100pF capacitor is charged to the specified voltage, then discharged through a $1.5 k\Omega$ resistor between two pins of the device. This is done for all couples of connected pin combinations while the other pins are floating.

^{3.} Machine model: a 200pF capacitor is charged to the specified voltage, then discharged directly between two pins of the device with no external series resistor (internal resistor $< 5\Omega$). This is done for all couples of connected pin combinations while the other pins are floating.

Charged device model: all pins and package are charged together to the specified voltage and then discharged directly to the ground through only one pin.

2 Typical application schematics

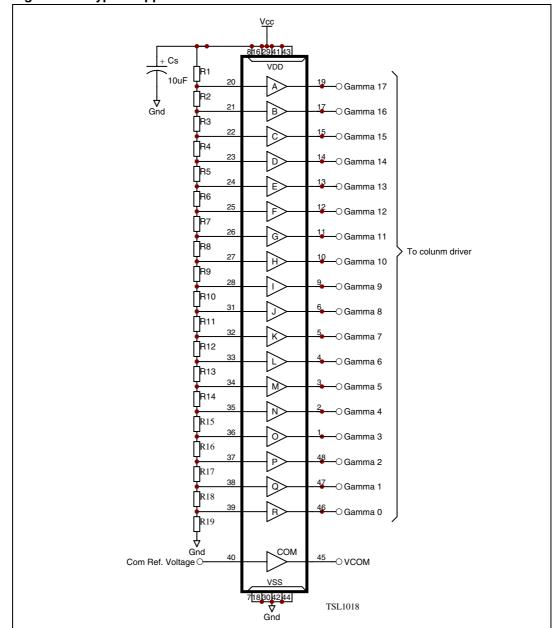


Figure 1. Typical application schematic for the TSL1018

Note that:

- Amplifiers A & B have their input voltages in the range V_{SS}+1.5V to V_{DD}. This is why
 they must be used for high level gamma correction voltages.
- Amplifiers C to R have their input voltages in the rangeV_{SS} to V_{DD}-1.5V. This is why
 they must be used for medium-to-low level gamma correction voltages.
- \bullet Amplifier COM has its input voltage range from V_{SS} to V_{DD} -1.5V.

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3 Electrical characteristics

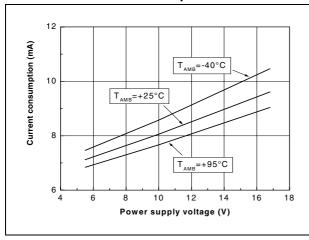
Table 3. Electrical characteristics for T_{amb} = 25°C , V_{DD} = +5V, V_{SS} = -5V, R_L = 10k Ω , C_L = 10pF (unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{IO}	Input offset voltage	V _{ICM} = 0V			12	mV
ΔV _{IO}	Input offset voltage drift	-40°C < T _{amb} < +85°C		5		μV/°C
I _{IB}	Input bias current	V _{ICM} = 0V, buffers A & B V _{ICM} = 0V, buffers C to R & COM			140 70	nA
R _{IN}	Input impedance			1		GΩ
C _{IN}	Input capacitance			1.35		pF
V _{OL}	Output voltage low	I _{OUT} = -5mA Buffers C to P Buffers Q, R & COM		-4.85 -4.92	-4.80 -4.85	V
V _{OH}	Output voltage high	I _{OUT} = 5mA for buffers A & B	4.82	4.87		V
1.	Output current	(A to R buffers)		±40		mA
l _{OUT}		COM buffer		±150		IIIA
PSRR	Power supply rejection ratio	V _{CC} = 6.5 to 15.5V	80	100		dB
I _{CC}	Supply current	No load		8	11	mA
SR	Slew rate (rising & falling edge)	-4V < V _{OUT} < +4V 20% to 80%		1.1		V/μs
t _s	Settling time	Settling to 0.1%, V _{OUT} =2V step		5		μs
BW	Bandwidth at -3dB	R _L =10kΩ, C _L =10pF		3.5		MHz
G _m	Phase margin	R _L =10kΩ, C _L =10pF		60		degrees
C _s	Channel separation	f=1MHz		75		dB

Note: Limits are 100% production tested at 25°C. Behavior at the temperature range limits is guaranteed through correlation and by design.

Figure 2. Supply current vs. supply voltage for various temperatures

Figure 3. Output offset voltage (eq. V_{IO}) vs. temperature



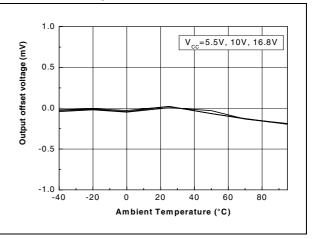
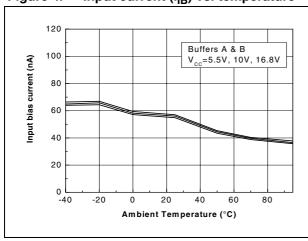


Figure 4. Input current (I_{IB}) vs. temperature

Figure 5. Input current (I_{IB}) vs. temperature



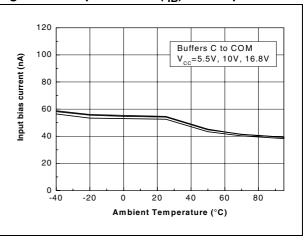
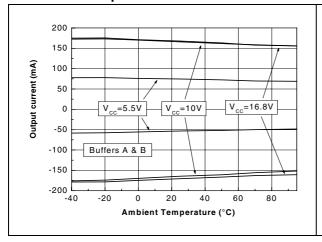
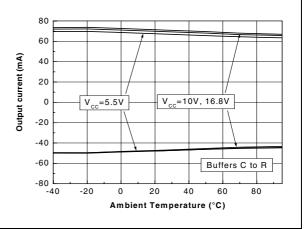


Figure 6. Output current capability vs. temperature

Figure 7. Output current capability vs. temperature





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Figure 8. Output current capability vs. temperature

V_{cc}=5.5V

Buffer COM

200

100

n

-100

-200

5.5

5.0

4.5

4.0

High level output voltage (V)

-40

Output current (mA)

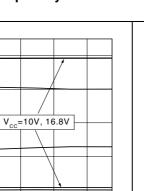


Figure 9. High level voltage drop vs. temperature

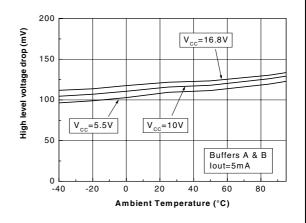


Figure 10. Low level voltage drop vs. temperature

40

Ambient Temperature (°C)

200 Low level voltage drop (mV) 160 = 5.5V120 V_{CC} = 10V, 16.8V 80 Buffers Q & R 40 lout = 5mA 0 L -40 -20 40 60 80 100 Temperature (°C)

Figure 11. Low level voltage drop vs. temperature

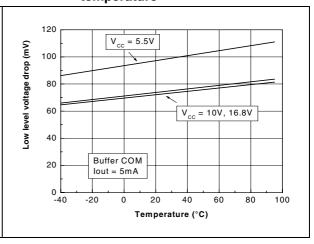


Figure 12. Voltage output high (V_{OH}) vs. output current - buffers A & B

T_{AMB}=+25°C

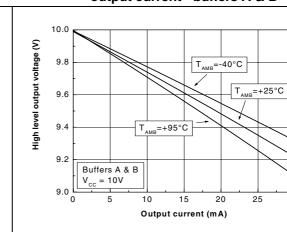
10

15

Output current (mA)

Buffers A & B

 $V_{cc} = 5.5V$



25

30

Voltage output high (V_{OH}) vs. Figure 13. output current - buffers A & B

6/15

30

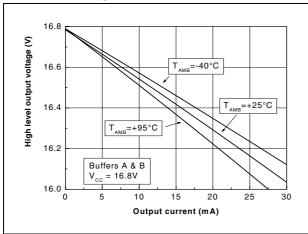
T_{AMB}=-40°C

 $T_{AMB} = +95^{\circ}C$

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Figure 14. Voltage output high (V_{OH}) vs. output current - buffers A & B

Figure 15. Voltage output low (V_{OL}) vs. output current - buffers C to P



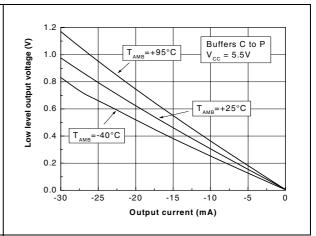
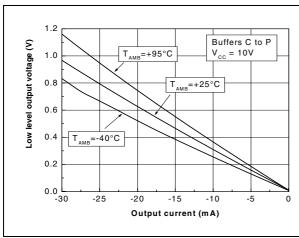


Figure 16. Voltage output low (V_{OL}) vs. output Figure 17. Voltage output low (V_{OL}) vs. output current - buffers C to P



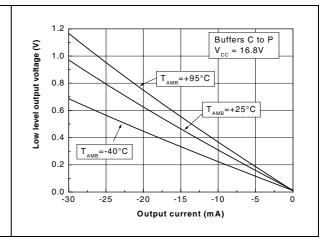
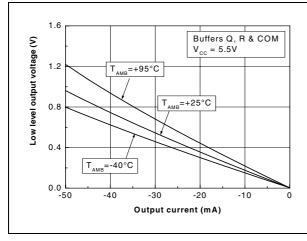
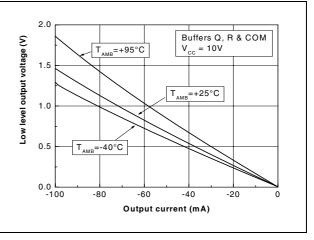


Figure 18. Voltage output low (V_{OL}) vs. output Figure 19. Voltage output low (V_{OL}) vs. output current - buffer Q, R & COM





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Figure 20. Voltage output low (V_{OL}) vs. output Figure 21. Positive slew rate vs. temperature current - buffer Q, R & COM

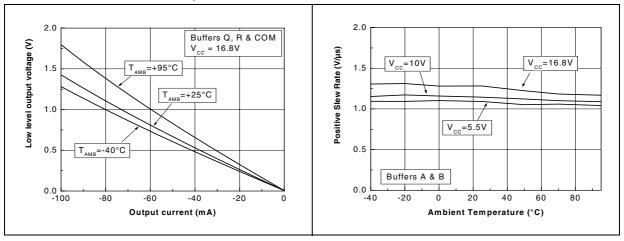


Figure 22. Positive slew rate vs. temperature Figure 23. Positive slew rate vs. temperature

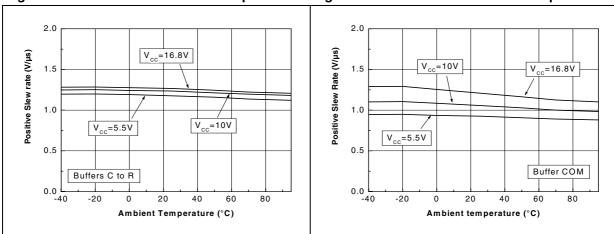


Figure 24. Negative slew rate vs. temperature Figure 25. Negative slew rate vs. temperature

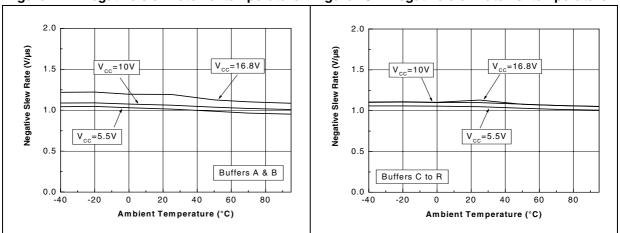
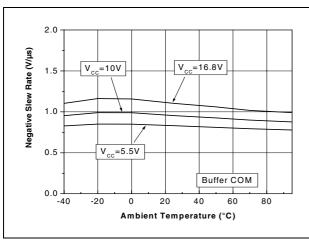


Figure 26. Negative slew rate vs. temperature Figure 27. Large signal response - buffers A & B



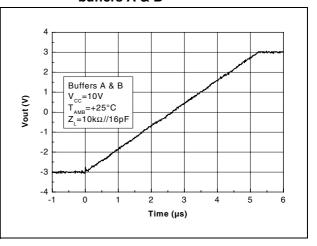
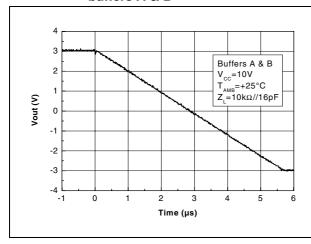


Figure 28. Large signal response - buffers A & B

Figure 29. Large signal response - buffers C to R



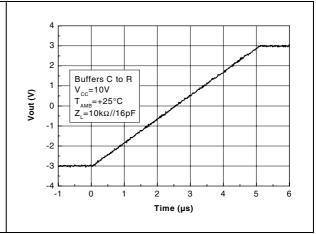
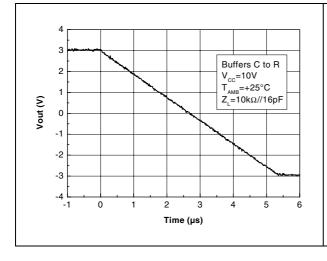
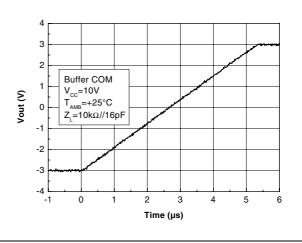


Figure 30. Large signal response - buffers C to R

Figure 31. Large signal response - buffer COM

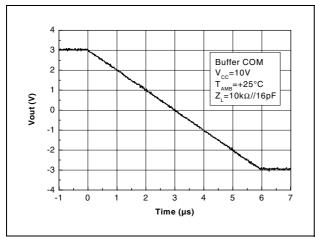




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Figure 32. Large signal response - buffer COM

Figure 33. Small signal response - buffers A & B



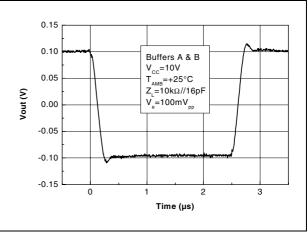
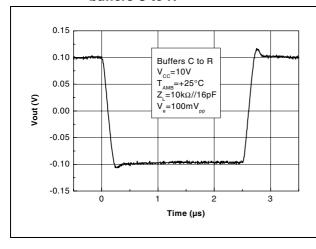


Figure 34. Small signal response - buffers C to R

Figure 35. Small signal response - buffer COM



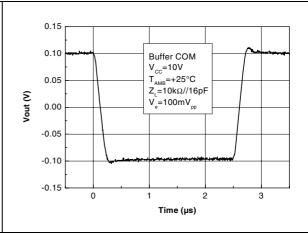
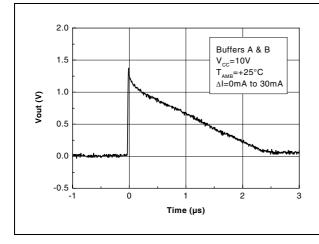


Figure 36. Output voltage response to current Figure 37. transient - buffers A & B

Output voltage response to current transient - buffers A & B



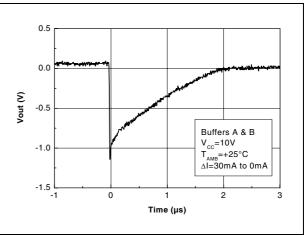


Figure 38. Output voltage response to current Figure 39. Output voltage response to current transient - buffers C to R transient - buffers C to R

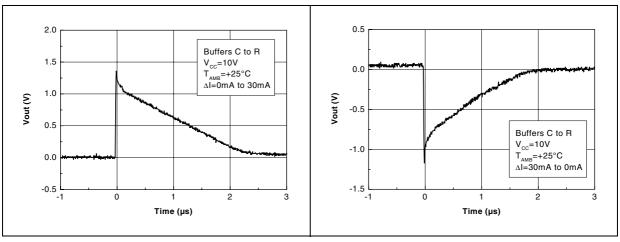


Figure 40. Output voltage response to current Figure 41. Output voltage response to current transient - buffer COM transient - buffer COM

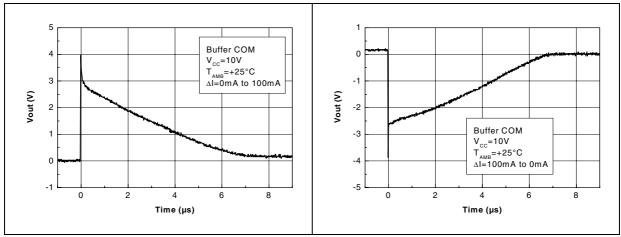
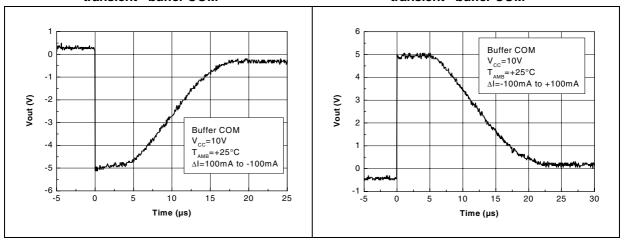


Figure 42. Output voltage response to current Figure 43. Output voltage response to current transient - buffer COM transient - buffer COM



Package information TSL1018

4 Package information

In order to meet environmental requirements, STMicroelectronics offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an STMicroelectronics trademark. ECOPACK specifications are available at: www.st.com.

Table 4. TQFP48 ePad package mechanical data

Table 4.	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
А			1.20			0.047	
A1	0.05		0.15	0.002		0.006	
A2	0.95	1.00	1.05	0.037	0.039	0.041	
b	0.17	0.22	0.27	0.007	0.009	0.011	
С	0.09		0.20	0.004		0.008	
D	8.80	9.00	9.20	0.346	0.354	0.362	
D1	6.80	7.00	7.20	0.268	0.276	0.283	
D2	2.00			0.079			
D3		5.50			0.217		
E	8.80	9.00	9.20	0.346	0.354	0.362	
E1	6.80	7.00	7.20	0.268	0.276	0.283	
E2	2.00			0.079			
E3		5.50			0.217		
е		0.50			0.020		
L	0.45	0.60	0.75	0.018	0.024	0.030	
L1		1.00			0.039		
k	0°	3.5°	7°	0°	3.5°	7°	
ccc			0.08			0.003	

TSL1018 Package information

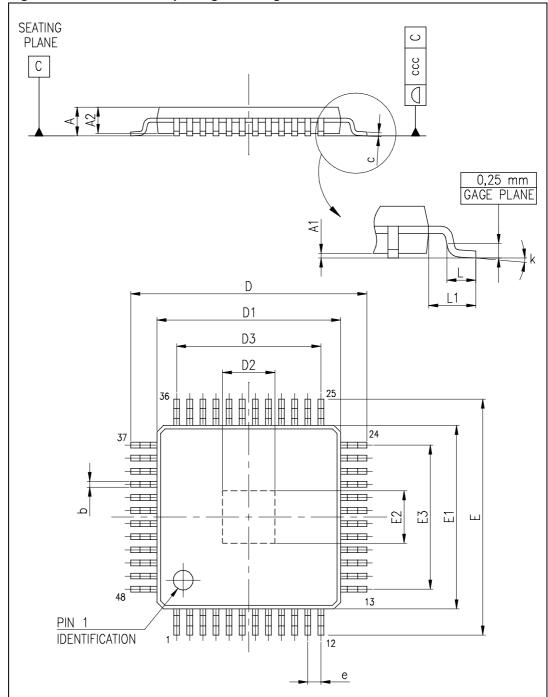


Figure 44. TQFP48 ePad package drawing

Ordering information TSL1018

5 Ordering information

Table 5. Order codes

Part number	Temperature range	Package	Packing	Marking
TSL1018IF	-40°C to +95°C	TQFP48 ePad	Tray	SL1018I
TSL1018IFT			Tape & reel	3610161

6 Revision history

Date	Revision	Changes
22-Mar-2007	1	Initial release.
15-Jul-2008	2	Modified I _{CC} typical and maximum values in <i>Table 3</i> . Updated all curves (<i>Figure 2</i> to <i>Figure 43</i>). Added ESD charged device model value in <i>Table 1</i> .

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